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74F676
16-Bit Serial/Parallel-In, Serial-Out Shift Register

General Description

The 74F676 contains 16 flip-flops with provision for synchronous parallel or serial entry and serial output. When the Mode (M) input is HIGH, information present on the parallel data (P_0–P_{15}) inputs is entered on the falling edge of the Clock Pulse ($\overline{CP}$) input signal. When M is LOW, data is shifted out of the most significant bit position while information present on the Serial (SI) input shifts into the least significant bit position. A HIGH signal on the Chip Select ($\overline{CS}$) input prevents both parallel and serial operations.
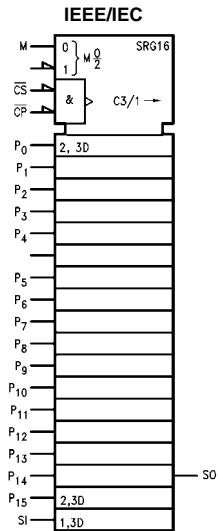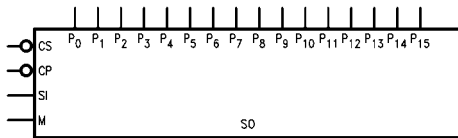
Features

■ 16-bit parallel-to-serial conversion
■ 16-bit serial-in, serial-out
■ Chip select control
■ Slim 24 lead 300 mil package
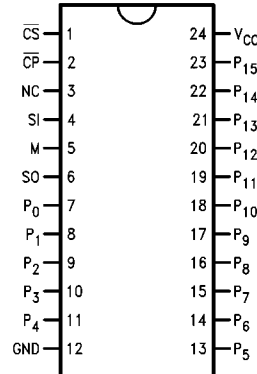
Ordering Code:

Order Number	Package Number	Package Description
74F676SC	M24B	24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
74F676PC	N24A	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-011, 0.600" Wide
74F676SPC	N24C	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols

IEEE/IEC

Connection Diagram

DS009588   www.fairchildsemi.com

Unit Loading/Fan Out

Pin Names	Description	U.L. HIGH/LOW	Input I_{IH}/I_{IL} Output I_{OH}/I_{OL}
P_0–P_{15}	Parallel Data Inputs	1.0/1.0	20 µA/–0.6 mA
$\overline{CS}$	Chip Select Input (Active LOW)	1.0/1.0	20 µA/–0.6 mA
$\overline{CP}$	Clock Pulse Input (Active LOW)	1.0/1.0	20 µA/–0.6 mA
M	Mode Select Input	1.0/1.0	20 µA/–0.6 mA
SI	Serial Data Input	1.0/1.0	20 µA/–0.6 mA
SO	Serial Output	50/33.3	–1 mA/20 mA

Functional Description

The 16-bit shift register operates in one of three modes, as indicated in the Shift Register Operations Table.

HOLD— a HIGH signal on the Chip Select ($\overline{CS}$) input prevents clocking, and data is stored in the sixteen registers.

Shift/Serial Load— data present on the SI pin shifts into the register on the falling edge of $\overline{CP}$. Data enters the Q_0 position and shifts toward Q_{15} on successive clocks, finally appearing on the SO pin.

Parallel Load— data present on P_0–P_{15} are entered into the register on the falling edge of $\overline{CP}$. The SO output represents the Q_{15} register output.
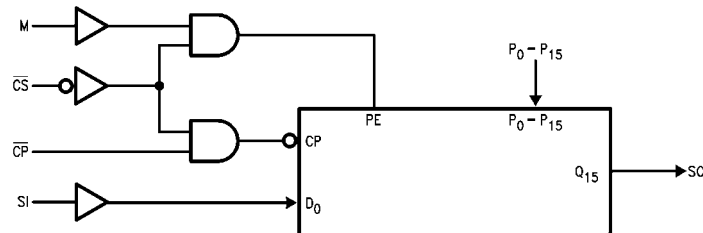
To prevent false clocking, $\overline{CP}$ must be LOW during a LOW-to-HIGH transition of $\overline{CS}$.

Shift Register Operations Table

Control Input			Operating Mode
$\overline{CS}$	M	$\overline{CP}$	
H	X	X	Hold
L	L	⌐_	Shift/Serial Load
L	H	⌐_	Parallel Load

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial
⌐_ = HIGH-to-LOW Transition

Block Diagram

Absolute Maximum Ratings(Note 1)

Storage Temperature	$-65°C$ to $+150°C$
Ambient Temperature under Bias	$-55°C$ to $+125°C$
Junction Temperature under Bias	$-55°C$ to $+150°C$
V_{CC} Pin Potential to Ground Pin	$-0.5V$ to $+7.0V$
Input Voltage (Note 2)	$-0.5V$ to $+7.0V$
Input Current (Note 2)	-30 mA to $+5.0$ mA
Voltage Applied to Output	
in HIGH State (with $V_{CC} = 0V$)	
Standard Output	$-0.5V$ to V_{CC}
3-STATE Output	$-0.5V$ to $+5.5V$
Current Applied to Output	
in LOW State (Max)	twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature	$0°C$ to $+70°C$
Supply Voltage	$+4.5V$ to $+5.5V$

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Symbol	Parameter		Min	Typ	Max	Units	V_{CC}	Conditions
V_{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V_{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal
V_{CD}	Input Clamp Diode Voltage				−1.2	V	Min	$I_{IN} = -18$ mA
V_{OH}	Output HIGH	10% V_{CC}	2.5			V	Min	$I_{OH} = -1$ mA
	Voltage	5% V_{CC}	2.7					$I_{OH} = -1$ mA
V_{OL}	Output LOW Voltage	10% V_{CC}			0.5	V	Min	$I_{OL} = 20$ mA
I_{IH}	Input HIGH Current				5.0	µA	Max	$V_{IN} = 2.7V$
I_{BVI}	Input HIGH Current Breakdown Test				7.0	µA	Max	$V_{IN} = 7.0V$
I_{CEX}	Output HIGH Leakage Current				50	µA	Max	$V_{OUT} = V_{CC}$
V_{ID}	Input Leakage Test		4.75			V	0.0	$I_{ID} = 1.9$ µA, All Other Pins Grounded
I_{OD}	Output Leakage Circuit Current				3.75	µA	0.0	$V_{IOD} = 150$ mV, All Other Pins Grounded
I_{IL}	Input LOW Current				−0.6	mA	Max	$V_{IN} = 0.5V$
I_{OS}	Output Short-Circuit Current		−60		−150	mA	Max	$V_{OUT} = 0V$
I_{CC}	Power Supply Current				72	mA	Max	

74F676

AC Electrical Characteristics

Symbol	Parameter	$T_A = +25°C$ $V_{CC} = +5.0V$ $C_L = 50$ pF			$T_A = -55°C$ to $125°C$ $V_{CC} = +5.0V$ $C_L = 50$ pF		$T_A = 0°C$ to $+70°C$ $V_{CC} = +5.0V$ $C_L = 50$ pF		Units
		Min	Typ	Max	Min	Max	Min	Max	
f_{MAX}	Maximum Clock Frequency	100	110		45		90		MHz
t_{PLH}	Propagation Delay	4.5	9.0	11.0	4.5	17.0	4.5	12.0	ns
t_{PHL}	$\overline{CP}$ to SO	5.0	9.0	12.5	5.0	14.5	5.0	13.5	

AC Operating Requirements

| Symbol	Parameter	$T_A = +25°C$ $V_{CC} = +5.0V$		$T_A = -55°C$ to $125°C$ $V_{CC} = +5.0V$		$T_A, V_{CC} = $_____ $V_{CC} = +5.0V$		Units
		Min	Max	Min	Max	Min	Max	
$t_S(H)$	Setup Time, HIGH or LOW	4.0		4.0		4.0		ns
$t_S(L)$	SI to $\overline{CP}$	4.0		4.0		4.0		
$t_H(H)$	Hold Time, HIGH or LOW	4.0		4.0		4.0		
$t_H(L)$	SI to $\overline{CP}$	4.0		4.0		4.0		
$t_S(H)$	Setup Time, HIGH or LOW	3.0		3.0		3.0		ns
$t_S(L)$	P_n to $\overline{CP}$	3.0		3.0		3.0		
$t_H(H)$	Hold Time, HIGH or LOW	4.0		4.0		4.0		
$t_H(L)$	P_n to $\overline{CP}$	4.0		4.0		4.0		
$t_S(H)$	Setup Time, HIGH or LOW	8.0		8.0		8.0		ns
$t_S(L)$	M to $\overline{CP}$	8.0		8.0		8.0		
$t_H(H)$	Hold Time, HIGH or LOW	2.0		2.0		2.0		
$t_H(L)$	M to $\overline{CP}$	2.0		2.0		2.0		
$t_S(L)$	Setup Time, LOW $\overline{CS}$ to $\overline{CP}$	10.0		12.0		10.0		ns
$t_H(H)$	Hold Time, HIGH $\overline{CS}$ to $\overline{CP}$	10.0		10.0		10.0		
$t_W(H)$	$\overline{CP}$ Pulse Width	4.0		5.0		4.0		ns
$t_W(L)$	HIGH or LOW	6.0		9.0		6.0		

Physical Dimensions inches (millimeters) unless otherwise noted
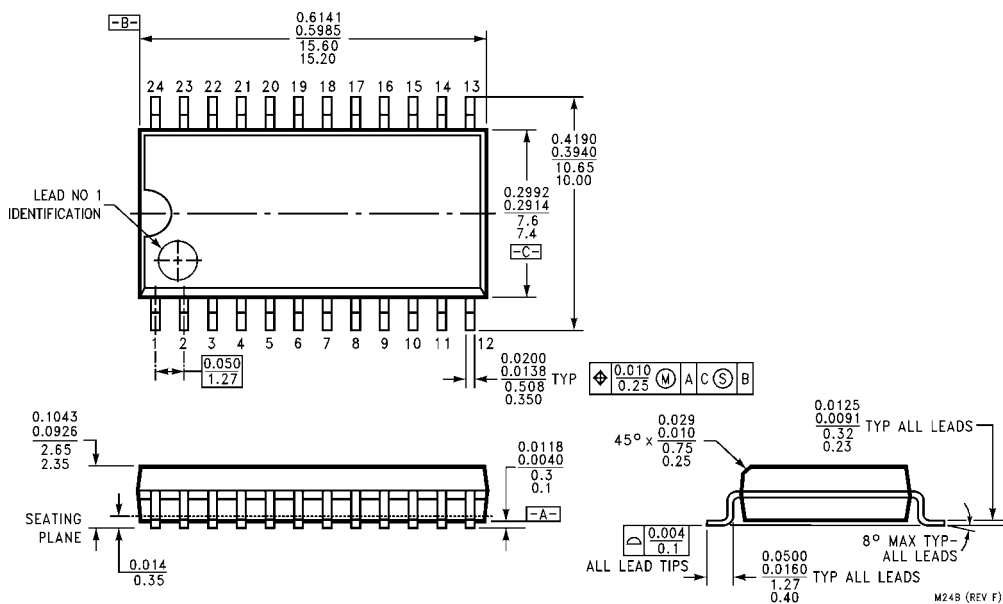
24-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide
Package Number M24B
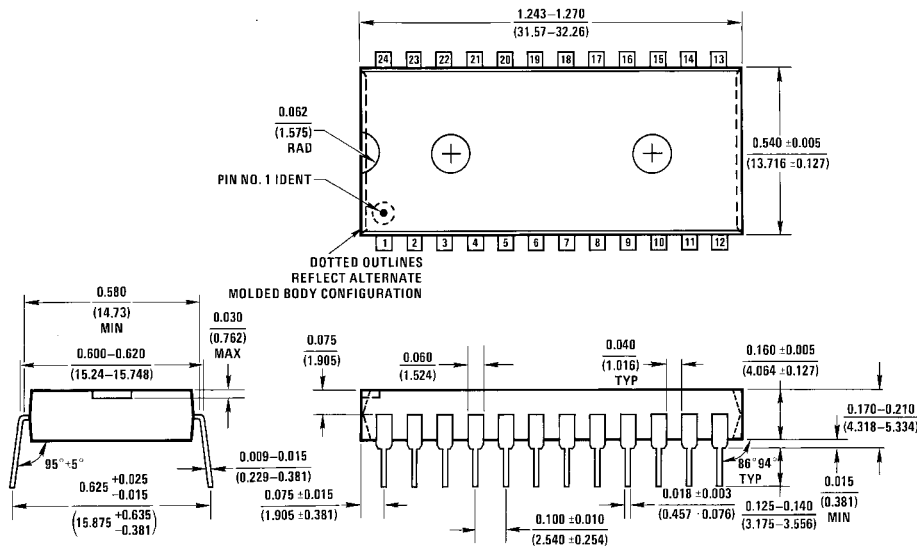
24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-011, 0.600" Wide
Package Number N24A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

**24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N24C**
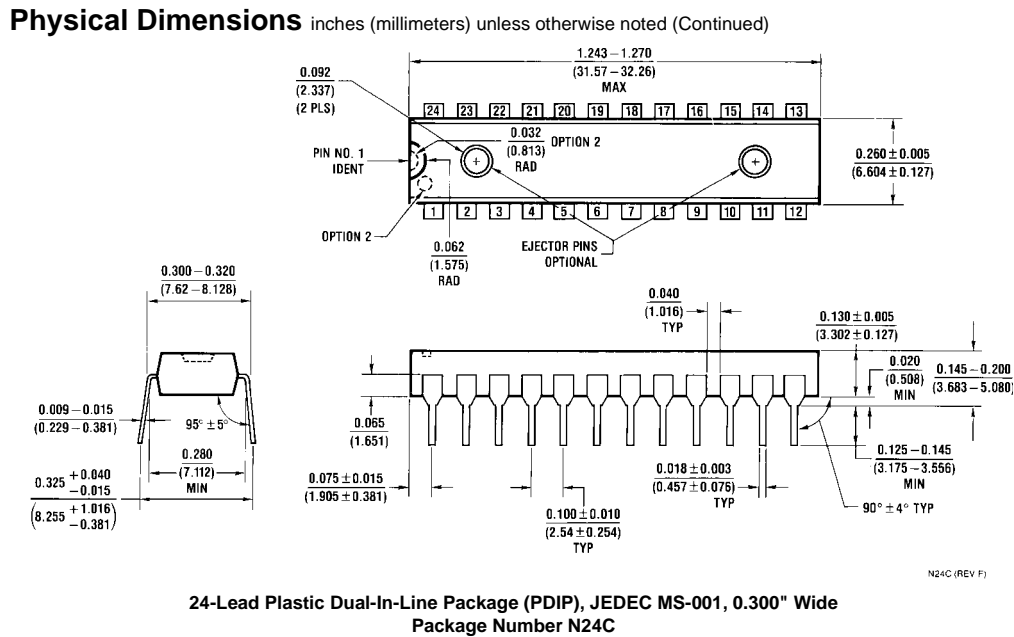
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